

OCT 27 2005

Certificate of Facsimile Transmission

I hereby certify that the attached Transmittal (1 page), Response to the Office Action dated July 28, 2005 (9 pages) PTO form 2038 authorizing credit card payment of \$100.00 for additional claims fee are submitted to the U.S. Patent and Trademark Office via facsimile number (571) 273-8300 on the date shown below. (Total 11 pages).


Li Mei Vermilya

Date: October 27, 2005

PATENT APPLICATION
Attorney Docket No.: 9898-197
Client Ref. No.: SS-15599-US

IN THE UNITED STATES PATENT AND TRADEMARK OFFICE

In re application of: Heon-Deok PARK, et al.

Serial No.: 10/003,180 Examiner: Kerveros, James C.

Filed: October 30, 2001 Group Art Unit: 2133

Confirmation No.: 4103

For: SEMICONDUCTOR TEST SYSTEM AND METHOD FOR
EFFECTIVELY TESTING A SEMICONDUCTOR DEVICE HAVING
MANY PINSMail Stop Amendment
Commissioner for Patents
P.O. Box 1450
Alexandria, VA 22313-1450

Responsive to the Office Action dated July 28, 2005, enclosed is an amendment in the above-identified application.

The fee has been calculated as shown below.

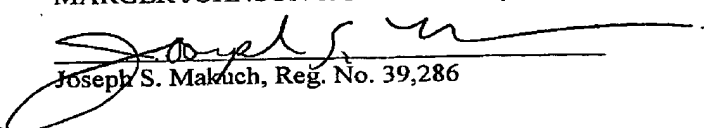
CLAIMS AS AMENDED					
For:	Number After Amendment	Previous Number	Extra	Rate	Additional Fee
Total Claims	22	20	2	x \$50 =	\$100
Independent Claims	4	4	0	x \$200 =	\$0
TOTAL ADDITIONAL FEE FOR THIS AMENDMENT					\$100

*greater of twenty (20) or number for which fee has been paid

**greater of three (3) or number for which fee has been paid

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Respectfully submitted,
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HAVING MANY PINSMail Stop Amendment
Commissioner for Patents
P.O. Box 1450
Alexandria, VA 22313-1450**AMENDMENT**Responsive to the Office Action, Paper No. 20050714, dated July 28, 2005, please
amend the application as follows.**Amendments to the Specification** begin on page 2 of this paper.**Amendments to the Claims** are reflected in the listing of claims which begins on
page 3 of this paper.**Remarks/Arguments** begin on page 7 of this paper.**RECEIVED
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OCT 28 2005

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